

Notice of References Cited

Application/Control No.

10/523,164

Applicant(s)/Patent Under
Reexamination
ALEXANDER ET AL.

Examiner

ROBERT LOEWE

Art Unit

1796

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2,684,349 A	07-1954	WHELTON JOHN J	524/425
*	B	US-4,385,158 A	05-1983	Mikami et al.	525/476
*	C	US-5,173,960 A	12-1992	Dickinson, Paul R.	385/100
*	D	US-5,523,059 A	06-1996	Langer, Roger L.	422/179
*	E	US-5,830,319 A	11-1998	Landin, Heather V.	162/159
*	F	US-6,153,668 A	11-2000	Gestner et al.	523/179
*	G	US-6,153,674 A	11-2000	Landin, Heather V.	524/35
*	H	US-6,521,834 B1	02-2003	Dykhoﬀ et al.	174/66
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2003100149 A	04-2003	Japan	NAKAMURA, SHOICHIRO	H01B 03/46
	O	JP 57130521	08-1982	Japan	MIZUTANI, NAKAMOTO	B 01 D 39/14
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	http://www.chance-hunt.com/ceepree/products/howitworks.htm
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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